


<b>Search Notes</b>  	<b>Application/Control No.</b>  10553095	<b>Applicant(s)/Patent Under Reexamination</b>  AOKI ET AL.
	<b>Examiner</b>  Wayne K Leung	<b>Art Unit</b>  4171

### SEARCHED

Class	Subclass	Date	Examiner
524	500	7/01/2008	/wkl/
106	287.11	12/16/2008	/DDL/
257	760	12/16/2008	/DDL/
427	126.2, 226, 340, 372.2, 373, 387, 397.7	12/16/2008	/DDL/
428	446, 701, 702	12/16/2008	/DDL/
438	637	12/16/2008	/DDL/
501	92, 96, 97, 98	12/16/2008	/DDL/
524	115, 122, 127, 236, 500, 858, 869, 588	12/16/2008	/DDL/
525	25, 26, 275, 28 38, 474, 475, 477	12/16/2008	/DDL/
528	14, 15, 18, 28, 29, 31, 33, 34, 38, 486, 490, 499, 503	12/16/2008	/DDL/
556	412, 413	12/16/2008	/DDL/

### SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search	7/01/2008	/wkl/
ISR search	7/01/2008	/wkl/
EAST search	7/01/2008	/wkl/
discussion with Walter Choi	7/01/2008	/wkl/
Updated inventor search	12/16/2008	/DDL/
Updated EAST search	12/16/2008	/DDL/
Review of case materials	12/16/2008	/DDL/
Search of Japanese patent literature	12/16/2008	/DDL/
Updated EAST search and Inventor search	10/27/2009	/DDL/

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner